

Search Notes

Application/Control No.

10/547,194

Examiner

Tran N. Nguyen

Applicant(s)/Patent under
Reexamination

ABOU-AKAR ET AL.

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	156.48	6/1	JNW
	156.49	12/1	
	156.55	10/7	
	156.56		
310	216	6/1	JNW
	261	12/1	
	162	10/7	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR